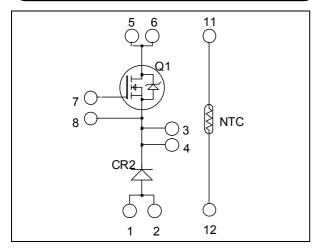
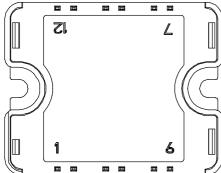


# Buck chopper Super Junction MOSFET SiC chopper diode





Pins 1/2; 3/4; 5/6 must be shorted together

# $V_{DSS} = 900V$ $R_{DSon} = 60m\Omega \text{ max } @ \text{Tj} = 25^{\circ}\text{C}$ $I_D = 59\text{A} @ \text{Tc} = 25^{\circ}\text{C}$

#### **Application**

- AC and DC motor control
- Switched Mode Power Supplies

#### **Features**

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- Ultra low R<sub>DSon</sub>
- Low Miller capacitance
- Ultra low gate charge
- Avalanche energy rated
- Very rugged

#### • CR1 SiC Schottky Diode

- Zero reverse recovery
- Zero forward recovery
- Temperature Independent switching behavior
- Positive temperature coefficient on VF
- Very low stray inductance
- Internal thermistor for temperature monitoring
- High level of integration

#### **Benefits**

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- RoHS Compliant

#### Absolute maximum ratings

Symbol	Parameter		Max ratings	Unit
$V_{ m DSS}$	Drain - Source Breakdown Voltage		900	V
т	Continuous Drain Current	$T_c = 25$ °C	59	
1 <sub>D</sub>	I <sub>D</sub> Continuous Drain Current	$T_c = 80$ °C	44	A
$I_{DM}$	Pulsed Drain current		150	
$V_{GS}$	Gate - Source Voltage		±20	V
R <sub>DSon</sub>	Drain - Source ON Resistance		60	mΩ
$P_{D}$	Maximum Power Dissipation	$T_c = 25^{\circ}C$	462	W
$I_{AR}$	Avalanche current (repetitive and non repetitive)		8.8	Α
E <sub>AR</sub>	Repetitive Avalanche Energy		2.9	mJ
$E_{AS}$	Single Pulse Avalanche Energy		1940	1113

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com



### All ratings @ $T_j = 25$ °C unless otherwise specified

### **Electrical Characteristics**

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{GS} = 0V, V_{DS} = 900V$ $T_j = 25^{\circ}C$			200	μА
		$V_{GS} = 0V, V_{DS} = 900V$ $T_j = 125^{\circ}C$		1000		
R <sub>DS(on)</sub>	Drain – Source on Resistance	$V_{GS} = 10V, I_D = 52A$		50	60	mΩ
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS} = V_{DS}$ , $I_D = 6mA$	2.5	3	3.5	V
$I_{GSS}$	Gate – Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$			200	nA

**Dynamic Characteristics** 

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
$C_{iss}$	Input Capacitance	$V_{GS} = 0V ; V_{DS} = 100V$		13.6		nF
$C_{oss}$	Output Capacitance	f = 1MHz		0.66		111
$Q_{g}$	Total gate Charge	$V_{GS} = 10V$		540		
$Q_{gs}$	Gate – Source Charge	$V_{\text{Bus}} = 400 \text{V}$		64		nC
$Q_{\mathrm{gd}}$	Gate – Drain Charge	$I_{D} = 52A$		230		
$T_{d(on)}$	Turn-on Delay Time	Inductive Switching (125°C)		70		ns
$T_{\rm r}$	Rise Time	$V_{GS} = 10V$		20		
$T_{d(off)}$	Turn-off Delay Time	$V_{Bus} = 600V$ $I_D = 52A$		400		
$T_{\mathrm{f}}$	Fall Time	$R_G = 3.8\Omega$		25		
Eon	Turn-on Switching Energy	Inductive switching @ 25°C		1.8		m I
$E_{\text{off}}$	Turn-off Switching Energy	$V_{GS} = 10V ; V_{Bus} = 600V$ $I_D = 52A ; R_G = 3.8\Omega$		1.5		mJ
Eon	Turn-on Switching Energy	Inductive switching @ 125°C		2.52		I
$E_{\text{off}}$	Turn-off Switching Energy	$V_{GS} = 10V ; V_{Bus} = 600V$ $I_D = 52A ; R_G = 3.8\Omega$		1.7		mJ

### CR2 SiC diode ratings and characteristics

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit	
$V_{RRM}$	Maximum Peak Repetitive Reverse Voltage		1200			V	
Ι	$I_{\rm DM}$   Maximim Reverse Leakage Current   $V_{\rm D}=1700V$	V_=1200V	$T_j = 25$ °C		96	600	μA
1KM		$T_j = 175$ °C		168	3000	μ2ι	
$I_F$	DC Forward Current	Tc = 100°C			30		A
V	Diode Forward Voltage	$I_{\rm D} = 30\Delta$	$T_i = 25^{\circ}C$		1.6	1.8	V
$V_{\rm F}$			$T_j = 175$ °C		2.3	3	V
Qc	Total Capacitive Charge	$I_F = 30A, V_R = di/dt = 1000A/\mu$		120		nC	
С	Total Campaitanas	$f = 1 \text{MHz}, V_R = 200V$ $f = 1 \text{MHz}, V_R = 400V$			288		n.E
	Total Capacitance				207		pF



### Thermal and package characteristics

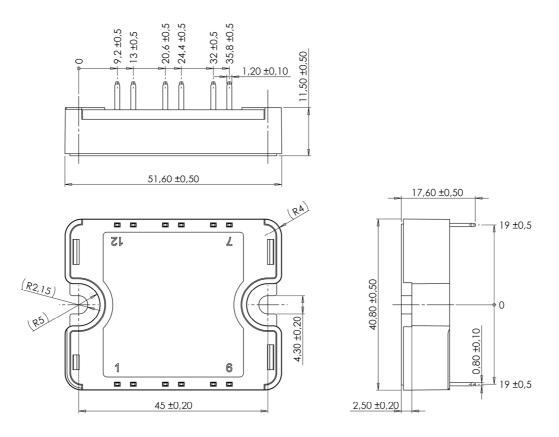
Symbol	Characteristic			Min	Тур	Max	Unit	
$R_{thJC}$	Junction to Case Thermal Resistance	CoolN	AOS			0.27	°C/W	
1\(\text{thJC}\)		SiC D	iode			0.63	C/W	
$V_{ISOL}$	RMS Isolation Voltage, any terminal to case t =1 min, 50/60Hz			4000			V	
$T_{J}$	Operating junction temperature range			-40		150		
$T_{STG}$	Storage Temperature Range			-40		125	°C	
$T_{\rm C}$	Operating Case Temperature				-40		100	
Torque	Mounting torque	To heats	ink	M4	2		3	N.m
Wt	Package Weight				80	g		

### Temperature sensor NTC (see application note APT0406 on www.microsemi.com for more information).

Symbol	Characteristic		Min	Typ	Max	Unit
R <sub>25</sub>	Resistance @ 25°C	C		50		kΩ
$\Delta R_{25}/R_{25}$				5		%
$B_{25/85}$	$T_{25} = 298.15 \text{ K}$			3952		K
$\Delta B/B$		T <sub>C</sub> =100°C		4		%

$$R_T = \frac{R_{25}}{\exp \left[ B_{25/85} \left( \frac{1}{T_{25}} - \frac{1}{T} \right) \right]}$$
 T: Thermistor temperature R<sub>T</sub>: Thermistor value at T

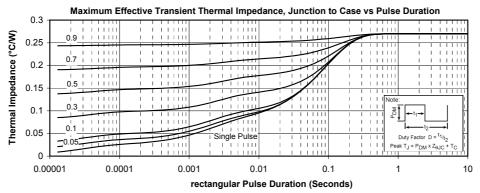
### SP1 Package outline (dimensions in mm)

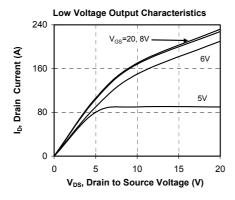


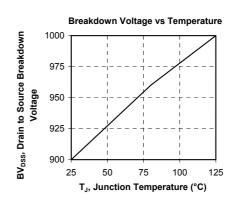
See application note 1904 - Mounting Instructions for SP1 Power Modules on www.microsemi.com

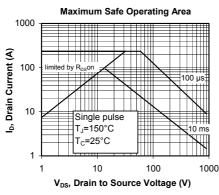


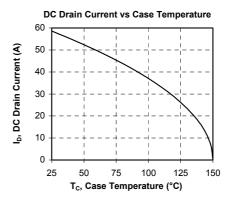
### **Typical CoolMOS Performance Curve**

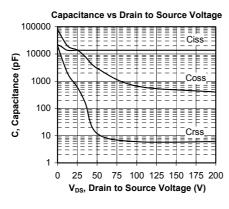


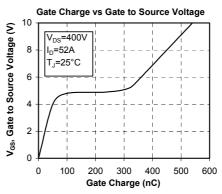






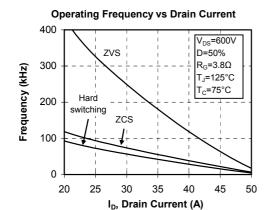


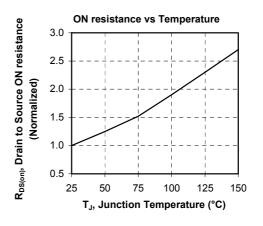


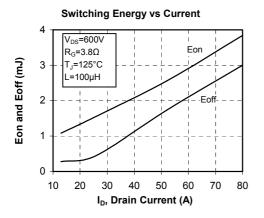


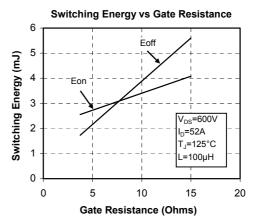
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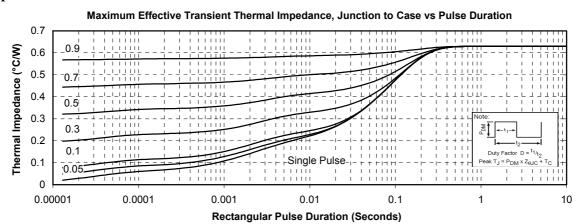


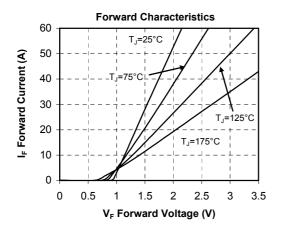


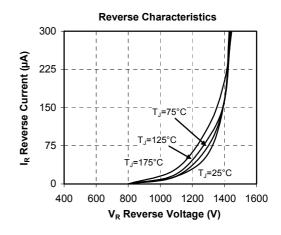


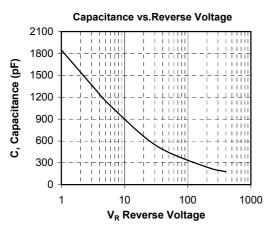


### **Typical CR2 SiC Diode Performance Curve**









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